

Notice of References Cited	Application/Control No. 10/632,110		Applicant(s)/Patent Under Reexamination EKIN ET AL.	
	Examiner DAVID CZEKAJ		Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,724,933	04-2004	Lin et al.	382/164
*	B	US-6,678,635	01-2004	Tovinkere et al.	702/179
*	C	US-2003/0063798	04-2003	Li et al.	382/165
*	D	US-6,810,144	10-2004	McGee et al.	382/166
*	E	US-7,027,509	04-2006	Jun et al.	375/240.16
*	F	US-7,110,454	09-2006	Chakraborty, Amit	375/240.16
*	G	US-6,144,375	11-2000	Jain et al.	715/251
*	H	US-7,027,513	04-2006	Zhang et al.	375/240.16
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	Q					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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